

MacroPixel Nal-14x25c-SiPM-T

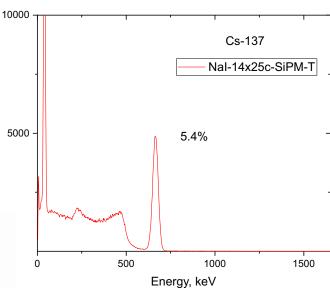
Description

Nal(TI) MacroPixel Nal-14x25c-SiPM-T is a traditional scintillator based solid state radiation detector made in the USA. Our proprietary encapsulation processes improve scintillation properties of NaI and combine them with all the benefits of cutting edge SiPM technology. Build-in temperature sensor allows precise monitoring of SiPM/crystal temperature. Nal-14x25c Scintillation Detector Assembly includes selected 14x14x25.4 mm NaI(TI) crystal coupled to 2x2 MicroFJ SiPM array with T-sensor on the back side of the carrier board.

Specifications					
Shape	Cuboid				
Detector type	Nal(TI)				
Detector size	14x14x25.4 mm				
Energy range	From 10 keV				
Typical resolution	6.5% at 662 keV				
Typical sensitivity to gamma radiation, cps/(µSv·h¹)	95 (¹³⁷ Cs)				
Readout	2x2 6mm SiPMs				
Dimensions	17x17x32 mm				
Weight	25 g				
Additional Features	Fast and standard outputs. Integrated temperature sensor				

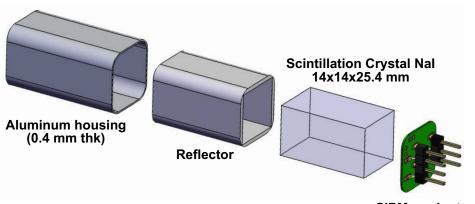
Benefits

- High sensitivity 5 cc of Nal scintillator
- Ultra compact design
- Fully solid state detector not sensitive to magnetic field
- Low bias requirements: 26-32V
- High signal amplitude (can be used without preamp)
- Sensor for Temperature-compensated Multichannel Analysis
- Operating temperature: -40 to 55 °C



Nal(TI) inorganic scintillation crystals have moderate light output of 40,000 photons/MeV, primary decay time about 250 ns, reasonable density of 3.7 g/cc, and peak emission wavelength about 415 nm.

Energy resolution of Nal-14x25c-SiPM-T is typically near 6.5% at 662 keV.



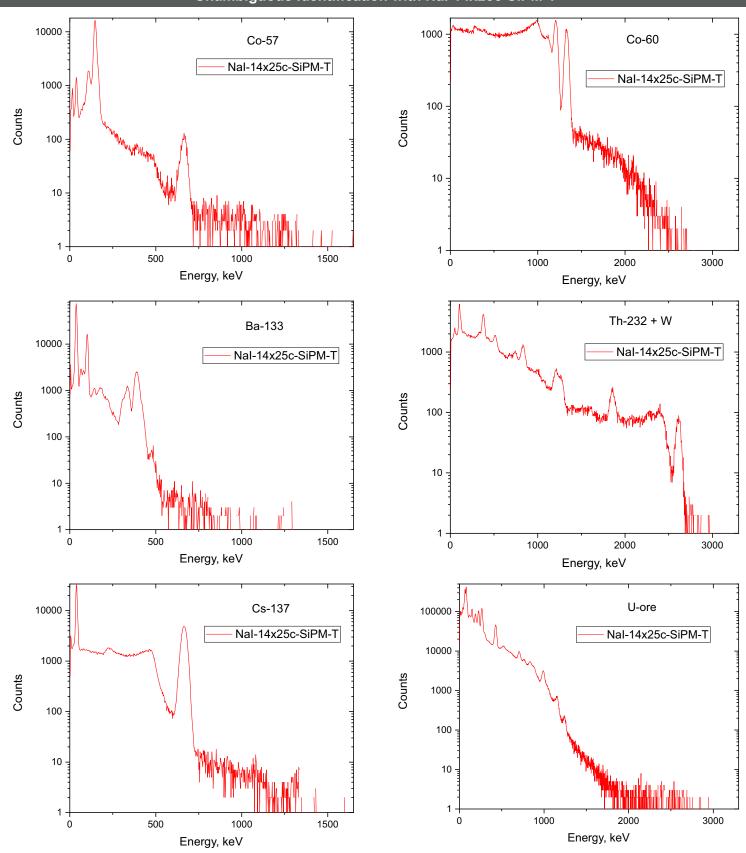
SiPM readout







Unambiguous Identification with Nal-14x25c-SiPM-T

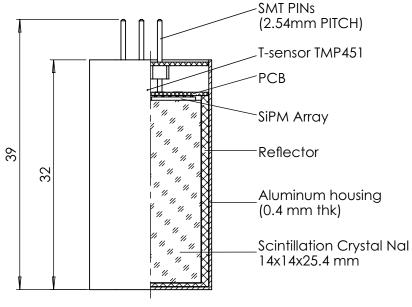




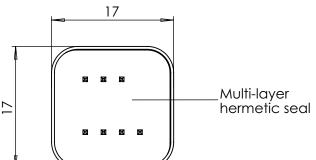


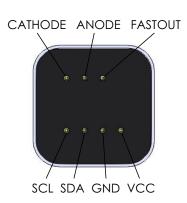


2D drawing

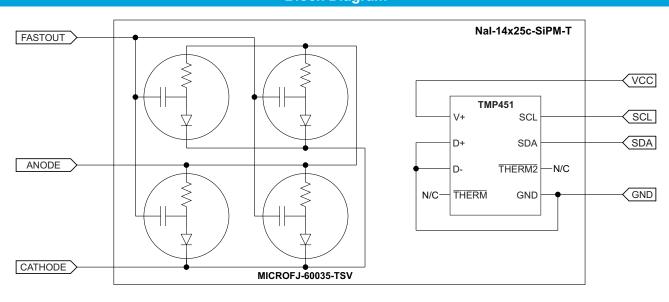








Block Diagram









Biasing Alternatives & Signal Polarity

This Appendix lists all of the possible ways in which a J-Series SiPM can be biased. For each biasing arrangement, the standard and fast signal polarities are given. **A** and **B** are the recommended configurations. **C** and **D** will work, but are not recommended for use with the fast output. The following abbreviations are used throughout:

Vbias = bias voltage

Sout = standard output

Fout = fast output

Rs = load resistor for the standard output

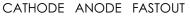
Rf = load resistor for the fast output

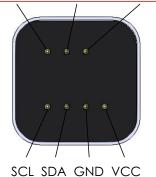
Vs = standard output voltage

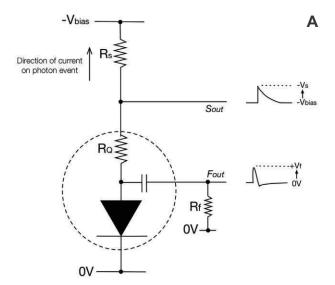
Vf = fast output voltage

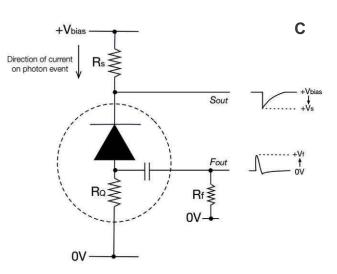
Rq = quench resistor (included on the SiPM die)

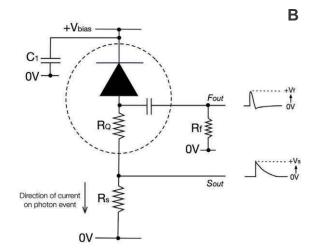
C1 = decoupling capacitor 10nF (50V), low ESR, ceramic

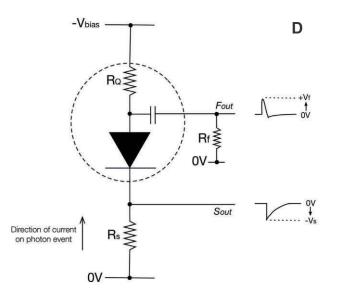












Ref.: J-Series High PDE and Timing Resolution, TSV Package, Datasheet, SensL



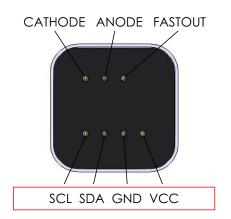




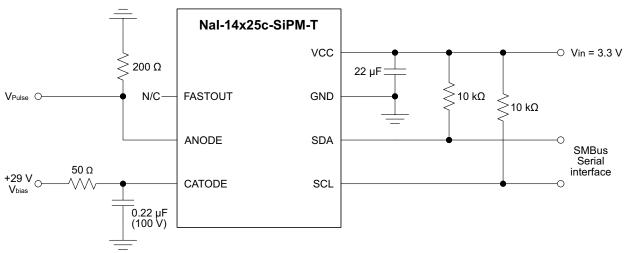
TMP451 Temperature Sensor

The TMP451 device is a high-accuracy, low-power remote temperature sensor monitor with a built-in local temperature sensor.

- ±1°C Accuracy Diode
- 1.7-V to 3.6-V Supply and Logic Voltage Range
- 27-µA Operating Current
- The temperature is represented as a 12-bit digital code
- Two-Wire and SMBus™ Serial Interface
- The sensor is (SANs) specified for operation over a supply voltage range of 1.7 V to 3.6 V and a temperature range of -40°C to 125°C.



Typical Application



Pin Functions

PIN NAME	TYPE	DESCRIPTION	
SCL	Digital input	Serial clock line for SMBus. Input; requires pullup resistor to voltage between 1.7 V and 3.6 V if driven by open-drain output.	
SDA	Bidirectional digital input-output	Serial data line for SMBus. Open-drain; requires pullup resistor to voltage between 1.7 V and 3.6 V.	
GND	Ground	Supply ground connection.	
VCC	Power supply	Positive supply voltage, 1.7 V to 3.6 V.	

Absolute Maximum Ratings

Over operating free-air temperature range, unless otherwise noted. (1)

	MIN	MAX	UNIT
Power supply (VCC)	-0.3	3.6	V
Input voltage (SDA and SCL)	-0.3	3.6	V
Input current		10	mA
Operating temperature	-55	127	°C
Junction temperature (TJmax)		150	°C
Storage temperature (Tstg)	-60	150	°C

⁽¹⁾ Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not implied.

Recommended Operating Conditions

Over operating free-air temperature range (unless otherwise noted)

	MIN	NOM	MAX	UNIT
Supply voltage	1.7	3.3	3.6	V
Operating free-air temperature (TA)	-40		125	°C

Ref.: TMP451 / SBOS686A – JUNE 2013 – REVISED DECEMBER 2014 / Texas Instruments





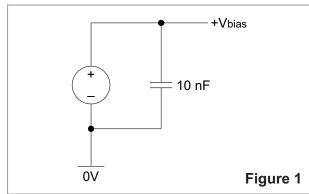


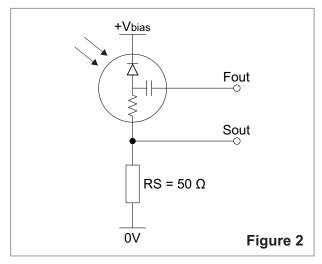


Application note: How to use "traditional" analog electronics with MacroPixel

To start acquiring spectra with MacroPixel is easy and straight-forward. The following example is for SC-14x25c-SiPM-T ScintiClear detector, but a similar approach can be utilized for all MacroPixel detectors. All you need is the following "traditional" analog electronics available in many labs dealing with scintillators and radiation measurements:

- 1) Stable programmable current source, capable of providing ripple-free bias up to +30 V and limited to 0.5 mA or three 9 V batteries. Apply this bias to the cathode of the MacroPixel. Additional filter can be used to minimize the noise coming from the power supply and connection lines (Figure 1).
- 2) There is no need to use a preamplifier. Signal can be monitored directly from the anode of the MicroPixel connected to the ground through a 50 Ohms (up to a 1000 Ohms) resistor (Figure 2). At +30 V bias a typical pulse corresponding to 3000 keV deposited energy is about 200mV in amplitude and 20 μ s long for SC-14x25c-SiPM-T.
- 3) Shaping spectroscopy amplifier. The most commonly available models are: Ortec 671, 672, and 673, and Canberra 2025 or 2026.
- 4) Multi-channel analyzer (MCA) with a software. In our example we used Ortec's Easy MCA with Maestro (Figure 3) but any other MCA can be used.





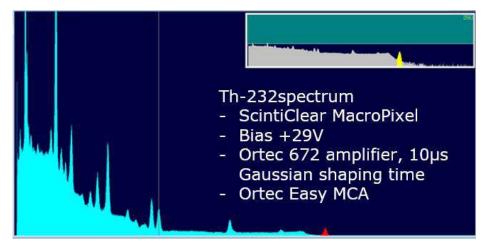


Figure 3

Th-232 emission spectrum measured with ScintiClear MacroPixel and "traditional" analog electronics. Bias +29 V, Ortec 672 amplifier, 10 μ s Gaussian shaping time, "+ NORM" input, 20 coarse gain

Standard and Custom Radiation Detectors







About CapeScint

CapeScint is a subsidiary of CapeSym, Inc. a multi-faceted company with 100+ years of combined experience in scintillators, semiconductors, and radiation detection instruments. CapeScint has its warehouse facilities and customer support staff located in Greater Boston Area, Massachusetts, USA.

Founded in 1992 as Cape Simulations, CapeSym, Inc. is now a multi-faceted company offering novel technical crystals and detectors for nuclear detection, including ScintiClear \mbox{TM} Srl₂(Eu) and ElpasoLight $\mbox{CLYC}(\mbox{Ce})$ scintillators. In addition, CapeSym offers radiation detection instruments and equipment through www.zievert.com.





Our ongoing R&D leverages decades of experience in crystal growth, solid state physics, analytical chemistry, materials science, thermo-fluid transport, and engineering design. CapeScint as a subsidiary of CapeSym, Inc. has a long history working with the US Government as a contractor and as a supplier of essential goods and services. During the last 30 years CapeSym, Inc. and supported missions of multiple US Government agencies including NASA, MDA, USAF, DoE, DTRA, NIH, CWMD, and US Navy.





Design and specifications are subject to change without notice

